

Is Now Part of



ON Semiconductor®

To learn more about ON Semiconductor, please visit our website at www.onsemi.com

Please note: As part of the Fairchild Semiconductor integration, some of the Fairchild orderable part numbers will need to change in order to meet ON Semiconductor's system requirements. Since the ON Semiconductor product management systems do not have the ability to manage part nomenclature that utilizes an underscore (_), the underscore (_) in the Fairchild part numbers will be changed to a dash (-). This document may contain device numbers with an underscore (_). Please check the ON Semiconductor website to verify the updated device numbers. The most current and up-to-date ordering information can be found at www.onsemi.com. Please email any questions regarding the system integration to Fairchild guestions@onsemi.com.

ON Semiconductor and the ON Semiconductor logo are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdf/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any EDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officer



May 2014

FDMS9620S

Dual N-Channel PowerTrench[®] MOSFET Q1: 30V, 16A, 21.5m Ω Q2: 30V, 18A, 13m Ω

Features

Q1: N-Channel

- Max $r_{DS(on)}$ = 21.5m Ω at V_{GS} = 10V, I_D = 7.5A
- Max $r_{DS(on)}$ = 29.5m Ω at V_{GS} = 4.5V, I_D = 6.5A

Q2: N-Channel

- Max $r_{DS(on)} = 13m\Omega$ at $V_{GS} = 10V$, $I_D = 10A$
- Max $r_{DS(on)}$ = 17m Ω at V_{GS} = 4.5V, I_D = 8.5A
- Low Qg high side MOSFET
- lacktriangle Low $r_{DS(on)}$ low side MOSFET
- Thermally efficient dual Power 56 package
- Pinout optimized for simple PCB design
- RoHS Compliant



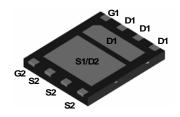
General Description

This device includes two specialized MOSFETs in a unique dual Power 56 package. It is designed to provide an optimal Synchronous Buck power stage in terms of efficiency and PCB utilization. The low switching loss "High Side" MOSFET is complemented by a Low Conduction Loss "Low Side" SyncFET.

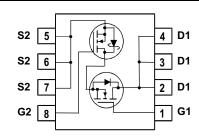
Applications

Synchronous Buck Converter for:

- Notebook System Power
- General Purpose Point of Load







MOSFET Maximum Ratings T_A = 25°C unless otherwise noted

Symbol	Paramete	r		Q1	Q2	Units
V_{DS}	Drain to Source Voltage			30	30	V
V_{GS}	Gate to Source Voltage			±20	±20	V
	Drain Current -Continuous	T _C = 25°C		16	18	
I _D	-Continuous	T _A = 25°C	(Note 1a)	7.5	10	Α
	-Pulsed			60	60	1
Б	Power Dissipation for Single Operation	T _A = 25°C	(Note 1a)			W
P_{D}		T _A = 25°C	(Note 1b)			VV
T _J , T _{STG}	Operating and Storage Junction Temperatur	e Range		-55 to	+150	°C

Thermal Characteristics

$R_{\theta JC}$	Thermal Resistance, Junction to Case		8.2	3.1	
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Not	e 1a)	50		°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient (Not	e 1b)	12	20	

Package Marking and Ordering Information

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMS9620S	FDMS9620S	Power 56	13"	12mm	3000 units

Electrical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Test Conditions	Type	Min	Тур	Max	Units
Off Chara	octeristics						
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = 250\mu A, V_{GS} = 0V$ $I_D = 1mA, V_{GS} = 0V$	Q1 Q2	30 30			V
$\frac{\Delta BV_{DSS}}{\Delta T_{J}}$	Breakdown Voltage Temperature Coefficient	I_D = 250 μ A, referenced to 25°C I_D = 1mA, referenced to 25°C	Q1 Q2		23 23		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = 24V, V _{GS} = 0V	Q1 Q2			1 500	μА
I _{GSS}	Gate to Source Leakage Current	V _{GS} = ±20V, V _{DS} = 0V	Q1 Q2			±100 ±100	nA

V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 250\mu A$ $V_{GS} = V_{DS}, I_D = 1mA$	Q1 Q2	1 1	1.6 1.6	3	٧
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate to Source Threshold Voltage Temperature Coefficient	I _D = 250μA, referenced to 25°C I _D = 1mA, referenced to 25°C	Q1 Q2		-4 -4		mV/°C
		$V_{GS} = 10V, I_D = 7.5A$ $V_{GS} = 4.5V, I_D = 6.5A$ $V_{GS} = 10V, I_D = 7.5A, T_J = 125^{\circ}C$	Q1	Q1 23 29		21.5 29.5 32	
r _{DS(on)}	Drain to Source On Resistance	$V_{GS} = 10V, I_D = 10A$ $V_{GS} = 4.5V, I_D = 8.5A$ $V_{GS} = 10V, I_D = 10A, T_J = 125^{\circ}C$	Q2		9 13 14	13 17 22	mΩ
g _{FS}	Forward Transconductance	$V_{DD} = 10V, I_D = 7.5A$ $V_{DD} = 10V, I_D = 10A$	Q1 Q2		25 27		S

Dynamic Characteristics

C _{iss}	Input Capacitance		Q1	500	665	pF
OISS	input Supusitanse		Q2	700	935	Pi
C	Output Conscitones		Q1	100	135	pF
C _{oss}	Output Capacitance	$V_{DS} = 15V, V_{GS} = 0V, f = 1MHZ$	Q2	500	665	þΓ
C	Dayaraa Transfer Canasitanaa		Q1	65	100	,r_
C _{rss}	Reverse Transfer Capacitance		Q2	100	150	pF
Б	Cata Basistanas	f = 1041 l=	Q1	0.9		0
R_g	Gate Resistance	f = 1MHz	Q2	1.8		Ω

Switching Characteristics

	9 · · · · · · · · · · · · · · · · · · ·				r	
t _{d(on)}	Turn-On Delay Time		Q1	11	20	ns
u(on)	,		Q2	15	27	
4	Rise Time		Q1	7	14	ns
۲	Nise Time	\/_ = - 15\/ - - 10	Q2	13	24	115
4	Turn-Off Delay Time	V_{DD} = 15V, I_{D} = 1A, V_{GS} = 10V, R_{GEN} = 6Ω	Q1	23	37	20
t _{d(off)}	Turn-On Delay Time	VGS = 10 V, NGEN = 052	Q2	27	44	ns
	Fall Time		Q1	2.3	10	
t _f	raii iiiile		Q2	7	14	ns
0	Total Cata Charge	Q1	Q1	10	14	~C
Q_g	Total Gate Charge	$V_{DD} = 15V, V_{GS} = 10V, I_{D} = 7.5A$	Q2	18	25	nC
0	Cata ta Sauraa Cata Charga		Q1	1.7		nC
Q_{gs}	Gate to Source Gate Charge	Q2	Q2	2.8		nc nc
		$V_{DD} = 15V, V_{GS} = 10V, I_{D} = 10A$	Q1	2.0		
Q_{gd}	Gate to Drain "Miller" Charge		Q2	3.6		nC
			-			

Electrical Characteristics $T_J = 25^{\circ}C$ unless otherwise noted

Parameter

Drain-S	Source Diode Characteristics						
Is	Maximum Continuous Drain-Source Dio	de Forward Current		Q1 Q2		2.1 3.5	Α
V _{SD}	Source to Drain Diode Forward Voltage	V _{GS} = 0V, I _S = 2.1A V _{GS} = 0V, I _S = 3.5A	(Note 2) (Note 2)	Q1 Q2	0.7 0.5	1.2 1.0	V
t _{rr}	Reverse Recovery Time	Q1 I _F = 7.5A, di/dt = 100A/μs		Q1 Q2	13 14		ns
Q _{rr}	Reverse Recovery Charge	Q2 I _F = 10A, di/dt = 300A/μs		Q1 Q2	4 9		nC

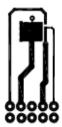
Test Conditions

Symbol

Notes:
 1: R_{θ,IA} is determined with the device mounted on a 1in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. R_{θ,IC} is guaranteed by design while R_{θ,CA} is determined by the user's board design.



a.50°C/W when mounted on a 1 in² pad of 2 oz copper



b. 120°C/W when mounted on a minimum pad of 2 oz copper

Min

Type

Тур

Max

Units

2: Pulse Test: Pulse Width < 300μ s, Duty cycle < 2.0%.

Typical Characteristics (Q1 N-Channel)T_J = 25°C unless otherwise noted

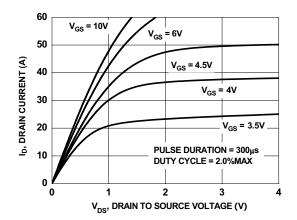


Figure 1. On Region Characteristics

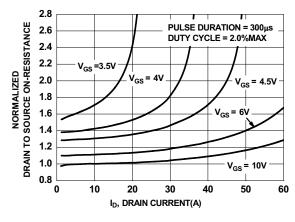


Figure 2. Normalized On-Resistance vs Drain Current and Gate Voltage

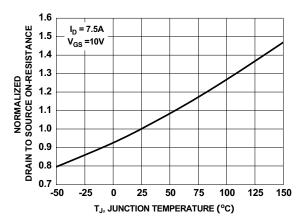


Figure 3. Normalized On Resistance vs Junction Temperature

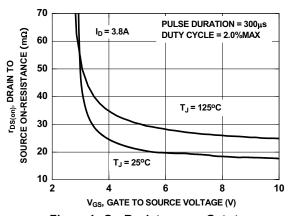


Figure 4. On-Resistance vs Gate to Source Voltage

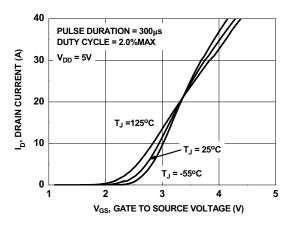


Figure 5. Transfer Characteristics

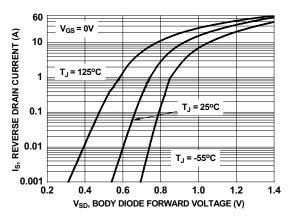


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics (Q1 N-Channel)T_J = 25°C unless otherwise noted

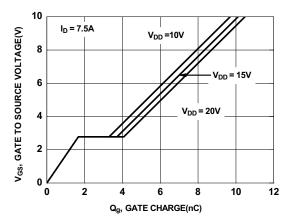


Figure 7. Gate Charge Characteristics

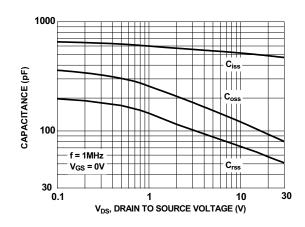


Figure 8. Capacitance vs Drain to Source Voltage

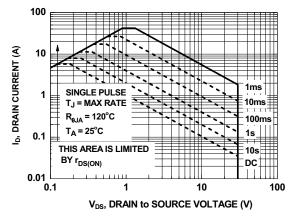


Figure 9. Forward Bias Safe Operating Area

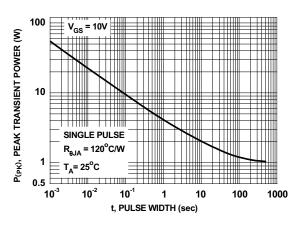


Figure 10. Single Pulse Maximum Power Dissipation

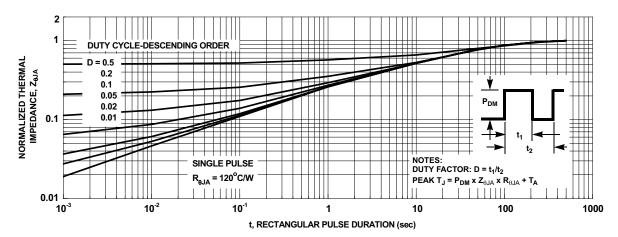


Figure 11. Transient Thermal Response Curve

Typical Characteristics (Q2 SyncFET)

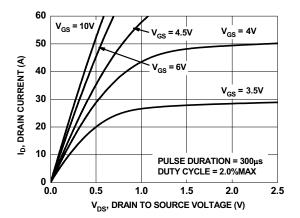


Figure 12. On-Region Characteristics

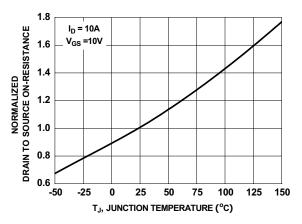


Figure 14. Normalized On-Resistance vs Junction Temperature

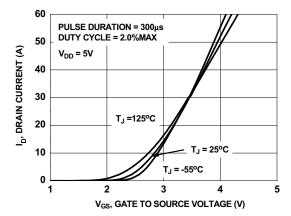


Figure 16. Transfer Characteristics

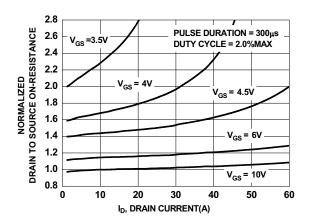


Figure 13. Normalized on-Resistance vs Drain Current and Gate Voltage

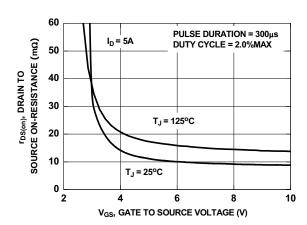


Figure 15. On-Resistance vs Gate to Source Voltage

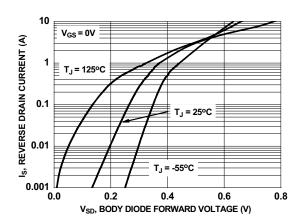


Figure 17. Source to Drain Diode Forward Voltage vs Source Current

Typical Characteristics

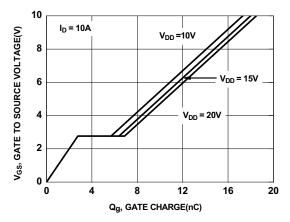


Figure 18. Gate Charge Characteristics

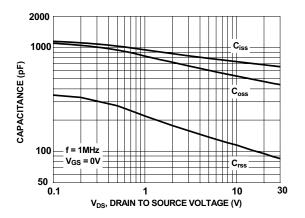
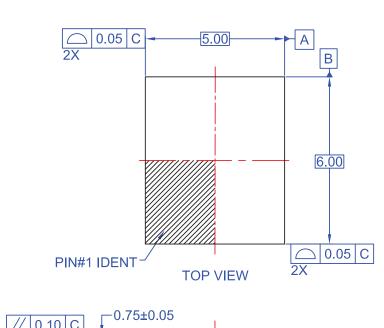
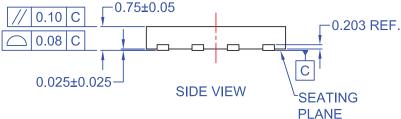
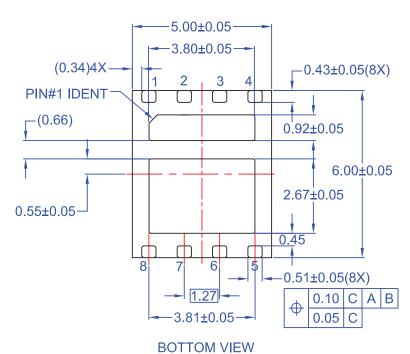
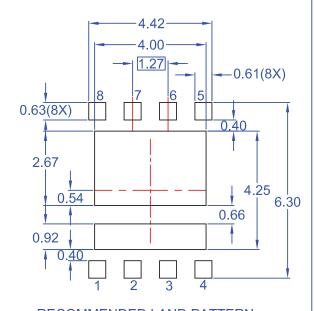


Figure 19. Capacitance vs Drain to Source Voltage









RECOMMENDED LAND PATTERN

NOTE:

- A. PACKAGE DOES NOT FULLY CONFORM TO JEDEC STANDARD.
- B. DIMENSIONS ARE IN MILLIMETERS.
- C. DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 2009.
- D. LAND PATTERN RECOMMENDATION IS EXISTING INDUSTRY LAND PATTERN.
- E. DRAWING FILENAME: MKT-MLP08Krev3.



ON Semiconductor and in are trademarks of Semiconductor Components Industries, LLC dba ON Semiconductor or its subsidiaries in the United States and/or other countries. ON Semiconductor owns the rights to a number of patents, trademarks, copyrights, trade secrets, and other intellectual property. A listing of ON Semiconductor's product/patent coverage may be accessed at www.onsemi.com/site/pdt/Patent-Marking.pdf. ON Semiconductor reserves the right to make changes without further notice to any products herein. ON Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. Buyer is responsible for its products and applications using ON Semiconductor products, including compliance with all laws, regulations and safety requirements or standards, regardless of any support or applications information provided by ON Semiconductor. "Typical" parameters which may be provided in ON Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. ON Semiconductor does not convey any license under its patent rights nor the rights of others. ON Semiconductor products are not designed, intended, or authorized for use as a critical component in life support systems or any FDA Class 3 medical devices or medical devices with a same or similar classification in a foreign jurisdiction or any devices intended for implantation in the human body. Should Buyer purchase or use ON Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold ON Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and exp

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor 19521 E. 32nd Pkwy, Aurora, Colorado 80011 USA Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com N. American Technical Support: 800-282-9855 Toll Free USA/Canada
Europe, Middle East and Africa Technical Support:
Phone: 421 33 790 2910
Japan Customer Focus Center
Phone: 81-3-5817-1050

ON Semiconductor Website: www.onsemi.com

Order Literature: http://www.onsemi.com/orderlit

For additional information, please contact your local Sales Representative